

Notice of References Cited	Application/Control No. 10/764,913		Applicant(s)/Patent Under Reexamination CHAN ET AL.	
	Examiner James M. Mitchell		Art Unit 2813	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0063364	03-2006	Stephens et al.	438/585
*	B	US-2006/0172498	08-2006	Yamaguchi et al.	438/287
*	C	US-2006/0273415	12-2006	Kim, Hyun Jung	257/413
*	D	US-2005/0215039	09-2005	Hill et al.	438/585
*	E	US-2004/0063261	04-2004	Takahashi, Akira	438/197
*	F	US-7,122,455	10-2006	Lyons et al.	438/585
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	O					
	P					
	Q					
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	T					

NON-PATENT DOCUMENTS

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